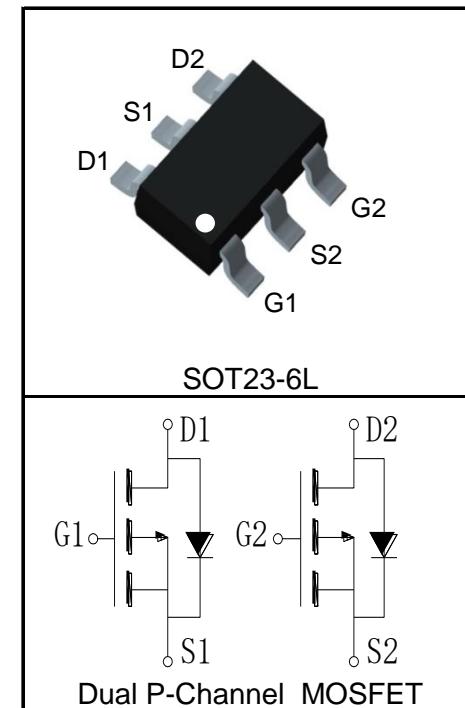


## Features

- -20V/-2.3A,  
 $R_{DS(ON)} = 90\text{m}\Omega$ (Typ.)@ $V_{GS}=-4.5\text{V}$
- $R_{DS(ON)} = 110\text{m}\Omega$ (Typ.)@ $V_{GS}=-2.5\text{V}$
- $R_{DS(ON)} = 130\text{m}\Omega$ (Typ.)@ $V_{GS}=-1.8\text{V}$
- Low  $R_{DS(ON)}$
- Super High Dense Cell Design
- Optimized Gate Charge to Minimize Switching Losses

## Pin Description



## Applications

- Load Switch
- Power Management



Halogen-Free

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
<b>Common Ratings</b> ( $T_A=25^\circ\text{C}$ Unless Otherwise Noted)			
$V_{DSS}$	Drain-Source Voltage	-20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 12$	
$T_J$	Maximum Junction Temperature	150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_S$	Diode Continuous Forward Current	$T_A=25^\circ\text{C}$	-1.1 A
<b>Mounted on Large Heat Sink</b>			
$I_{DP}^{(1)}$	300 $\mu\text{s}$ Pulse Drain Current Tested	$T_A=25^\circ\text{C}$	-9 A
$I_D^{(2)}$	Continuous Drain Current( $V_{GS}=-4.5\text{V}$ )	$T_A=25^\circ\text{C}$	-2.3 A
		$T_A=70^\circ\text{C}$	-1.8 A
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	1 W
		$T_A=70^\circ\text{C}$	0.64 W
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	80 $^\circ\text{C/W}$	
$R_{\theta JA}^{(3)}$	Thermal Resistance-Junction to Ambient	125 $^\circ\text{C/W}$	
<b>Drain-Source Avalanche Ratings</b>			
$E_{AS}^{(4)}$	Avalanche Energy, Single Pulsed	TBD	mJ

**Electrical Characteristics** ( $T_A=25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Test Condition	KS2501EA6			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=-250\mu\text{A}$	-20			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-20\text{V}, V_{\text{GS}}=0\text{V}$			-1	$\mu\text{A}$
		$T_J=125^\circ\text{C}$			-30	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=-250\mu\text{A}$	-0.5	-0.7	-1.1	V
$I_{\text{GSS}}$	Gate Leakage Current	$V_{\text{GS}}=\pm 12\text{V}, V_{\text{DS}}=0\text{V}$			$\pm 100$	nA
$R_{\text{DS}(\text{ON})}^{(5)}$	Drain-Source On-state Resistance	$V_{\text{GS}}=-4.5\text{V}, I_{\text{DS}}=-2\text{A}$		90	115	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}, I_{\text{DS}}=-2\text{A}$		110	150	$\text{m}\Omega$
		$V_{\text{GS}}=-1.8\text{V}, I_{\text{DS}}=-1\text{A}$		130	190	$\text{m}\Omega$
<b>Diode Characteristics</b>						
$V_{\text{SD}}^{(5)}$	Diode Forward Voltage	$I_{\text{SD}}=-2\text{A}, V_{\text{GS}}=0\text{V}$		-0.9	-1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_{\text{SD}}=-2\text{A}, dI_{\text{SD}}/dt=-100\text{A}/\mu\text{s}$		13		ns
$Q_{\text{rr}}$	Reverse Recovery Charge			8		nC
<b>Dynamic Characteristics</b> <sup>(6)</sup>						
$R_G$	Gate Resistance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$		1.8		$\Omega$
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-10\text{V}, \text{Frequency}=1.0\text{MHz}$		290		$\text{pF}$
$C_{\text{oss}}$	Output Capacitance			55		
$C_{\text{rss}}$	Reverse Transfer Capacitance			30		
$t_{\text{d}(\text{ON})}$	Turn-on Delay Time	$V_{\text{DD}}=-10\text{V}, I_{\text{DS}}=-2\text{A}, V_{\text{GEN}}=-4.5\text{V}, R_G=6\Omega$		10		ns
$t_r$	Turn-on Rise Time			6		
$t_{\text{d}(\text{OFF})}$	Turn-off Delay Time			21		
$t_f$	Turn-off Fall Time			8		
<b>Gate Charge Characteristics</b> <sup>(6)</sup>						
$Q_g$	Total Gate Charge	$V_{\text{DS}}=-10\text{V}, V_{\text{GS}}=-4.5\text{V}, I_{\text{DS}}=-2\text{A}$		2.9		nC
$Q_{\text{gs}}$	Gate-Source Charge			0.5		
$Q_{\text{gd}}$	Gate-Drain Charge			0.7		

Notes:

- ①Pulse width limited by safe operating area.

- ②Calculated continuous current based on maximum allowable junction temperature.

- ③When mounted on 1 inch square copper board,  $t \leq 10\text{sec}$ . The value in any given application depends on the user's specific board design.

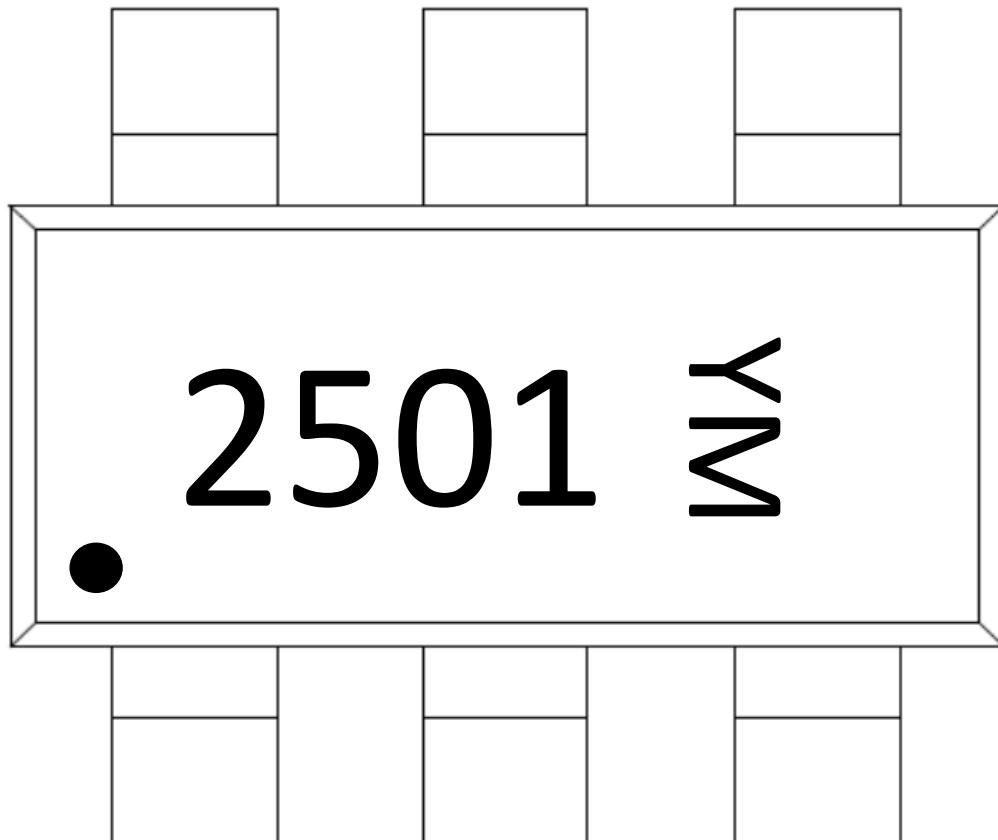
- ④Limited by  $T_{J\text{max}}$ . Starting  $T_J = 25^\circ\text{C}$ .

- ⑤Pulse test; Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

- ⑥Guaranteed by design, not subject to production testing.

**Ordering and Marking Information**

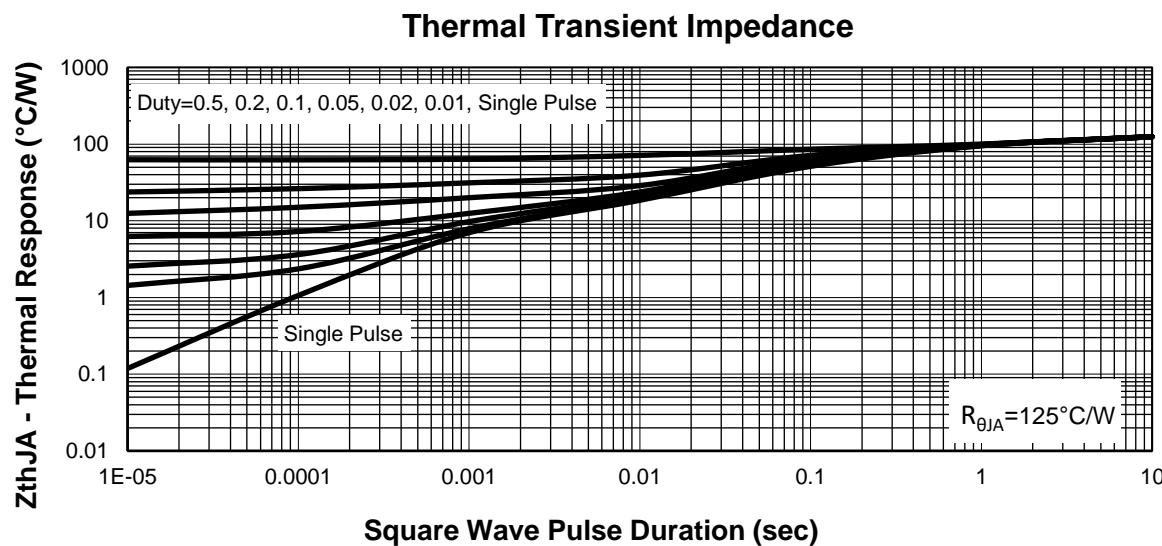
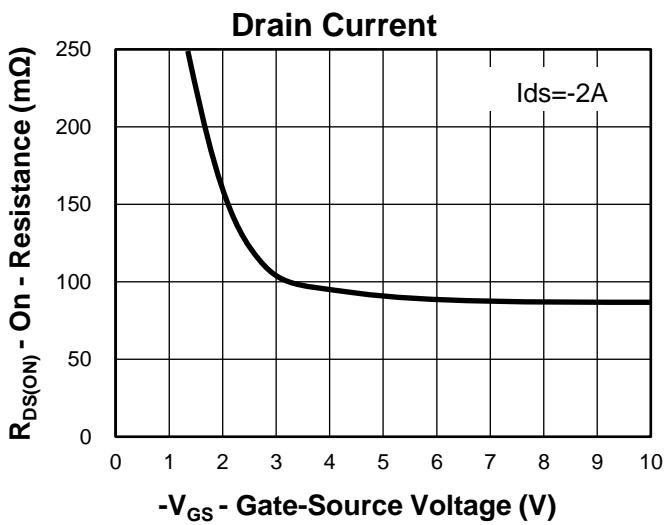
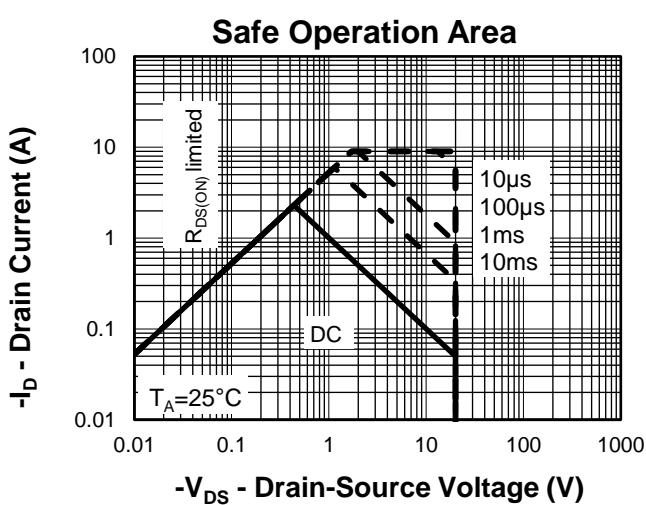
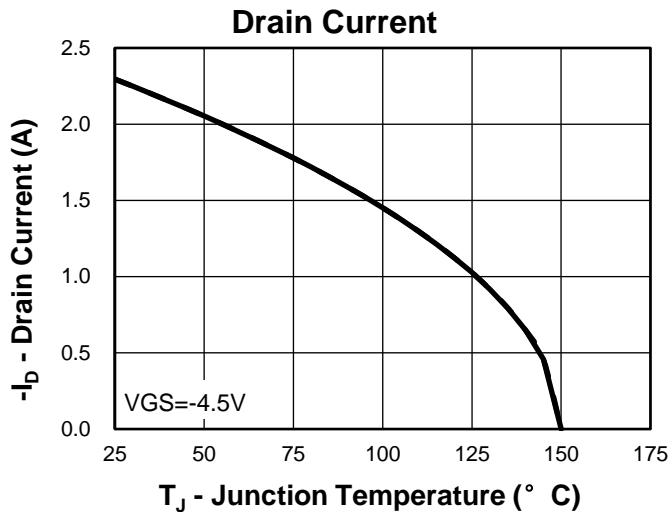
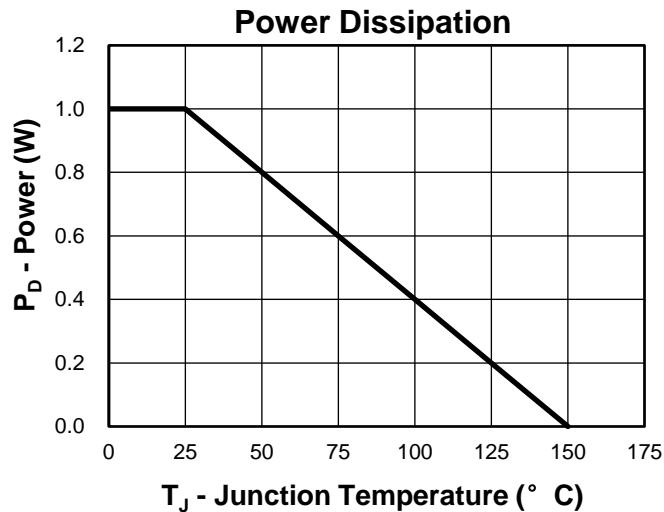
Device	Package	Packaging	Quantity	Reel Size	Tape width
KS2501EA6	SOT23-6L	Tape&Reel	3000	7"	8mm



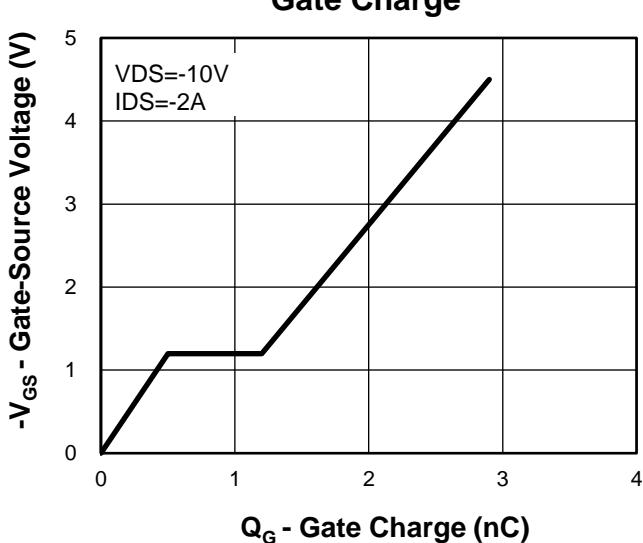
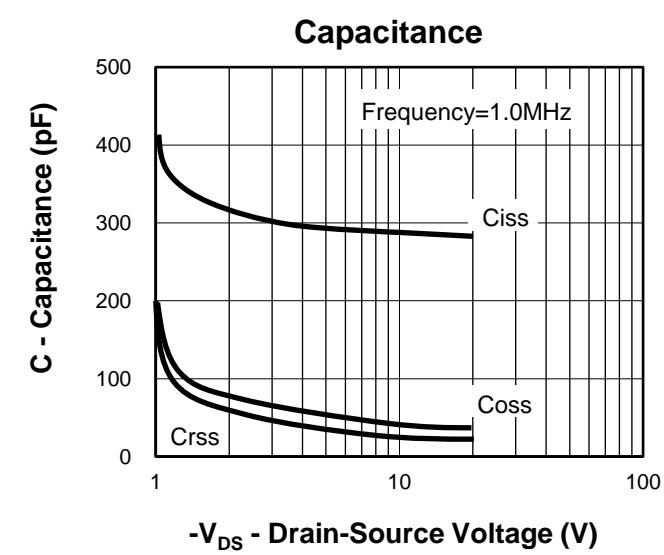
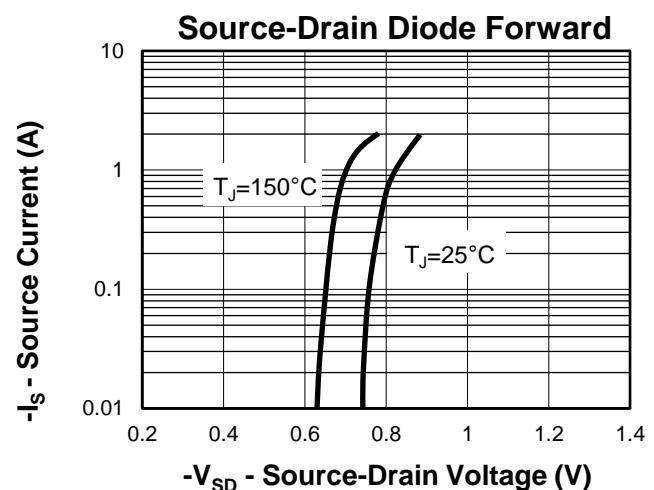
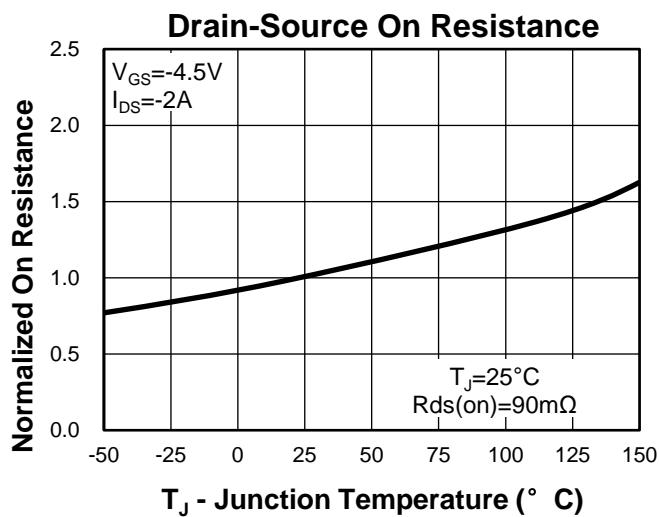
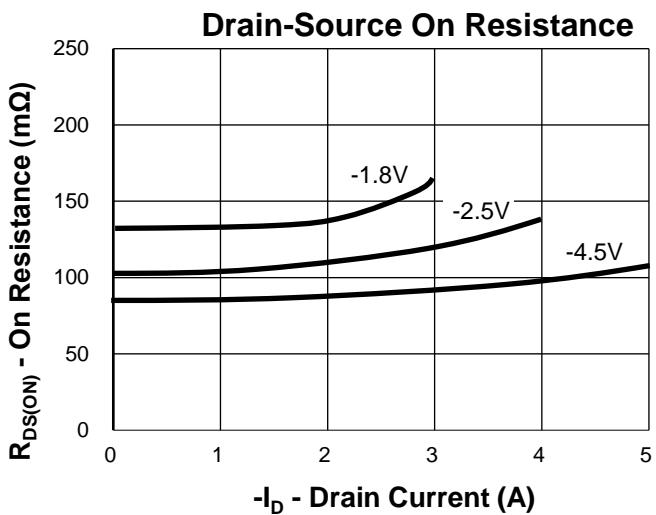
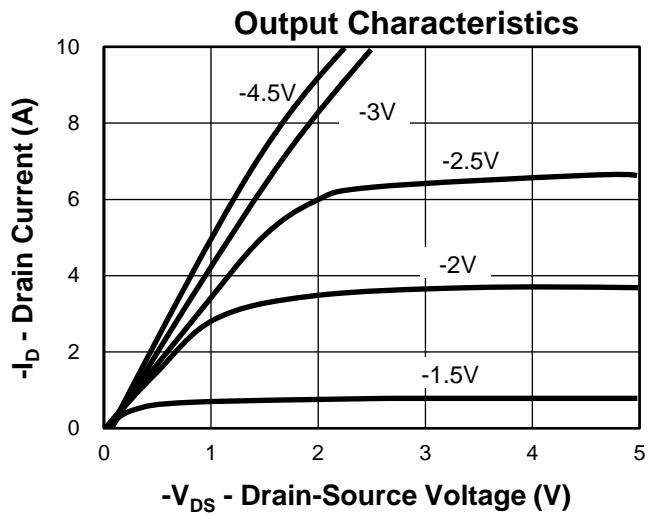
Y =Year,2017-A,2018-B,etc.

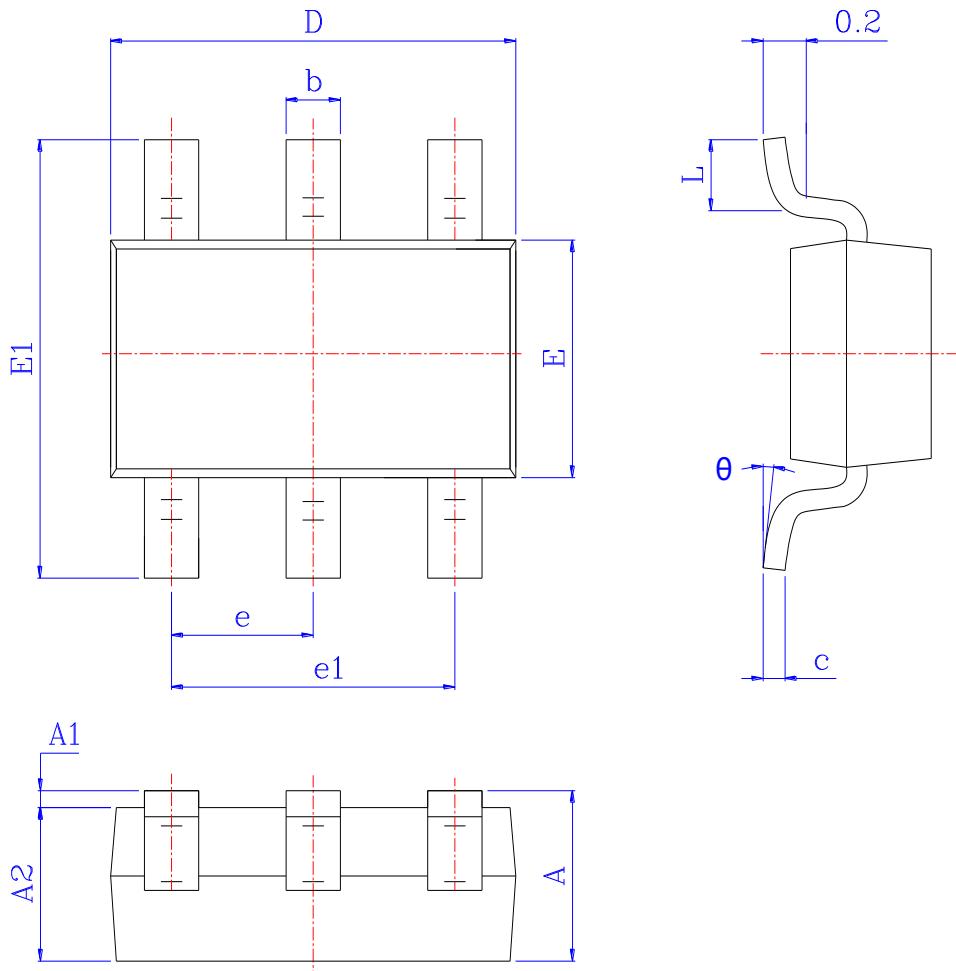
M =Month,Jan-1,Feb-2,...,Sep-9,Oct-A,Nov-B,Dec-C.

## Typical Characteristics



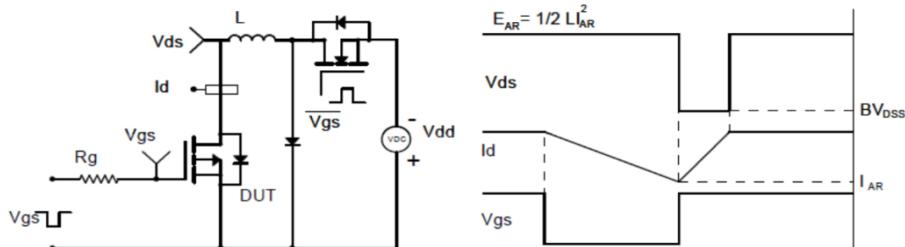
## Typical Characteristics



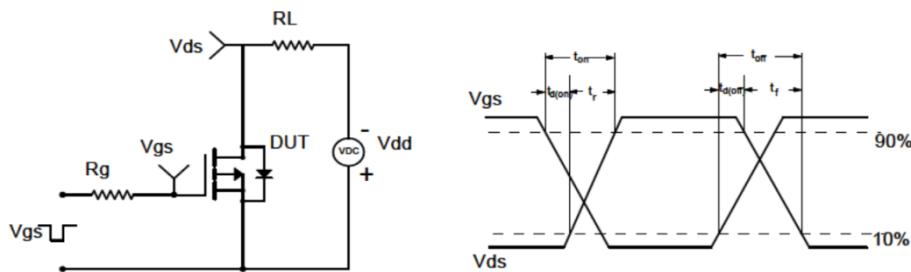
**Package Information**
**SOT23-6L**


SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.950	1.150	1.450	0.037	0.045	0.057
A1	0.000	0.060	0.150	0.000	0.002	0.006
A2	0.900	1.100	1.300	0.035	0.043	0.051
b	0.300	0.400	0.500	0.012	0.016	0.020
c	0.080	0.140	0.200	0.003	0.006	0.008
D	2.800	2.900	3.050	0.110	0.114	0.120
E	1.500	1.600	1.750	0.059	0.063	0.069
E1	2.600	2.800	3.000	0.102	0.110	0.118
e	0.950BSC			0.037BSC		
e1	1.800	1.900	2.000	0.071	0.075	0.079
L	0.300	0.450	0.600	0.012	0.018	0.024
theta	0°	4°	8°	0°	4°	8°

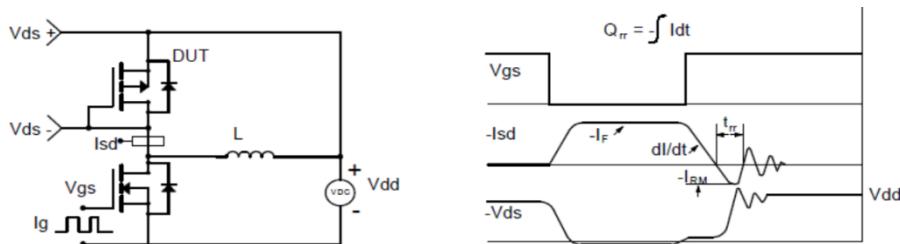
### Avalanche Test Circuit and Waveforms



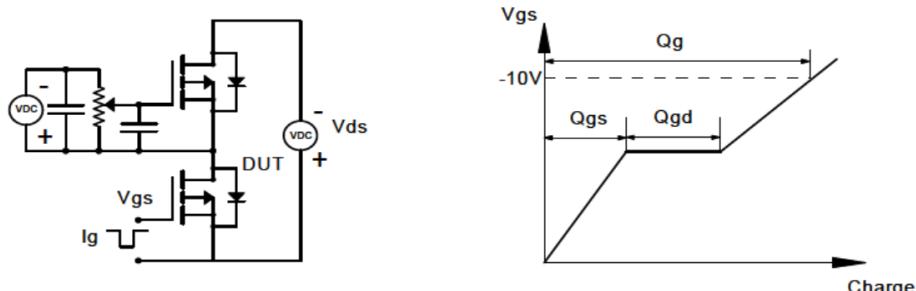
### Switching Time Test Circuit and Waveforms



### Diode Recovery Test Circuit and Waveforms



### Gate Charge Test Circuit and Waveform



### Customer Service

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Web:[www.kwansemi.com](http://www.kwansemi.com)

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